

Application/Control No.	Applicant(s)/Patent under Reexamination
10/737,296	BAE, SUNG HO
Examiner	Art Unit
Hashem Farrokh	2187

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM and East Inventor Search Conducted	1/13/2006	HF		
leee Xplore Search conducted	2/5/2006	HF		
Nasser Moazzami Consulted	1/13/2006	HF		
Hiep Nguyen Consulted	2/5/2006	HF		
East Search (US- PGBUB,UPSAT,USCOR,EPO,JPO,D ERWENT,IBM-TDB	2/5/2006	HF		
711/ALL (Text Search see Printout)	2/5/2006	HF		
713/ALL (Text Search see Printout)	2/5/2006	HF		
365/ALL (Text Search see Printout)	2/5/2006	HF		